

<b>INFORMATION DISCLOSURE CITATION</b>  <i>JUL 28 2004</i> <i>PTI/TRADEMARK OFFICE</i>	Atty. Docket No.: 10305US02	Serial No.: 10/822,884
	Applicant(s): Yip et al.	
	Filing Date: 04/13/2004	Group: 2182

**U.S. PATENT DOCUMENTS**

Examiner Initial	Document Number	Date	Name	Class	SubClass	Filing Date If Appropriate
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<b>TQN</b>  <i>↓</i>	"What's in a name?" IDP Technology – Key Features, IDP website <a href="http://idptech.com/features.htm">http://idptech.com/features.htm</a> ; pp. 1-3
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TQN		JP 05189861	07/1993	Japan			Abstract Only	
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